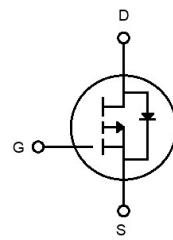


• General Description

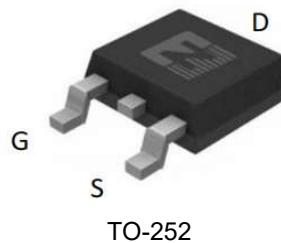
It combines trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$.

• Features

- Low $R_{DS(ON)}$ to minimize conductive loss
- High GOX reliability
- Low Thermal resistance


 $V_{DS} = -60V$
 $R_{DS(ON)} = 12m\Omega$
 $I_D = -50A$
• Application

- BLDC Motor driver
- DC-DC
- Load Switch


• Ordering Information:

Part NO.	ZM120P06D			
Marking	ZM120P06			
Packing Information	REEL TAPE			
Basic ordering unit (pcs)	2500			

• Absolute Maximum Ratings ($T_c=25^\circ C$)

Parameter	Symbol	Conditions	Value	Unit
Drain-Source Voltage	V_{DS}		-60	V
Gate-Source Voltage	V_{GS}		± 20	V
Continuous Drain Current	I_D	$T_c=25^\circ C$	-50	A
	I_D	$T_c=75^\circ C$	-39	A
	I_D	$T_c=100^\circ C$	-32	A
Pulsed Drain Current	I_{DM}	Pulsed; $t_p \leq 10 \mu s$; $T_{mb} = 25^\circ C$	-200	A
Total Power Dissipation	P_D	$T_c=25^\circ C$	89	W
Total Power Dissipation	P_D	$T_A=25^\circ C$	2.0	W
Operating Junction Temperature	T_J		-55 to +150	°C
Storage Temperature	T_{STG}		-55 to +150	°C
Single Pulse Avalanche Energy	E_{AS}	$L=0.1mH$, $V_{GS}=-10V$, $R_g=25\Omega$,	120	mJ
		$L=0.5mH$, $V_{GS}=-10V$, $R_g=25\Omega$,	252	mJ
ESD Level (HBM)			CLASS 2	

•Thermal resistance

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	R _{thJC}		-	1.4	°C/W
Thermal resistance, junction-ambient ^①	R _{thJA}		-	62	°C/W
Soldering temperature(total time<10s)	T _{sold}		-	260	°C

•Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =-250uA	-60			V
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} =V _{DS} , I _D =-250uA	-1.3	-1.8	-2.5	V
Drain-Source Leakage Current	I _{DSS}	V _{GS} =0V, V _{DS} = -60V			1.0	uA
Gate- Source Leakage Current	I _{GSS}	V _{GS} =±20V, V _{DS} = 0V			100	nA
Static Drain-source On Resistance	R _{DS(ON)}	V _{GS} =-10V, I _D = -16A		12	17	mΩ
		V _{GS} =-4.5V, I _D = -12A		16	23	mΩ
Forward Transconductance	g _{FS}	V _{DS} =-5V, I _{SD} = -10A		25		s
Diode Forward Voltage	V _{FSD}	V _{GS} =0V, I _{SD} = -16A			1.3	V

•Dynamic characteristics

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Input capacitance	C _{iss}	f = 1MHz, V _{DS} =-25V	-	7300	-	pF
Output capacitance	C _{oss}		-	355	-	
Reverse transfer capacitance	C _{rss}		-	272	-	
Gate Resistance	R _g	f = 1MHz	-	4		Ω
Total gate charge	Q _g	V _{DD} = -15V, I _D = -16A, V _{GS} = -10V	-	103	-	nC
	Q _{g(-4.5v)}		-	41	-	
Gate - Source charge	Q _{gs}		-	14	-	
Gate - Drain charge	Q _{gd}		-	15	-	
Turn-ON Delay time	t _{D(on)}	V _{GS} =-10V, V _{DS} =-15V, R _G =3.3Ω, I _D =-20A	-	16	-	ns
Turn-ON Rise time	t _r		-	25	-	ns
Turn-Off Delay time	t _{D(off)}		-	112	-	ns
Turn-Off Fall time	t _f		-	50	-	ns
Reverse Recovery Time	t _{RR}	V _{DD} =-20V, dI _S /dt = 100A/us, I _S =-20A	-	74	-	ns
Reverse Recovery Charge	Q _{RR}		-	287	-	nC

Fig.1 Gate-Charge Characteristics

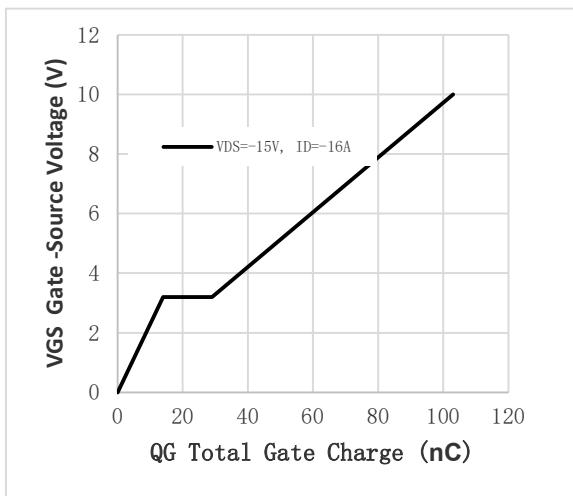


Fig.2 Capacitance Characteristics

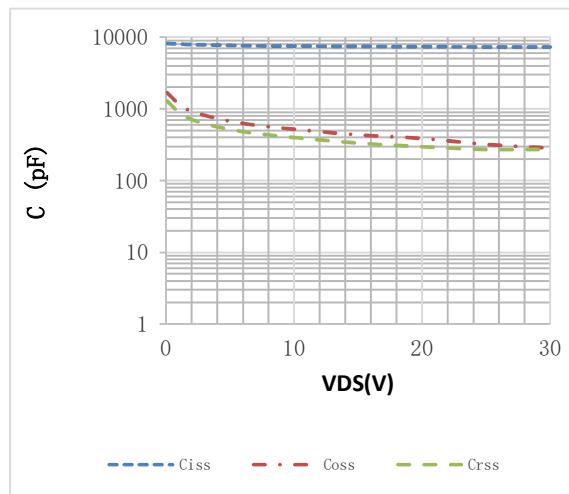


Fig.3 Power Dissipation

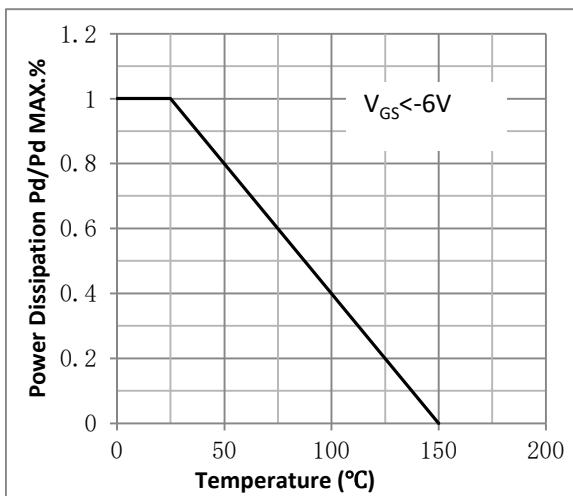


Fig.4 Typical output Characteristics

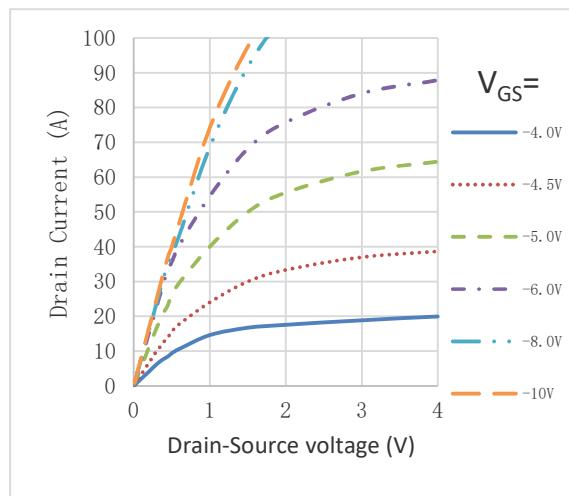


Fig.5 Threshold Voltage V.S Junction Temperature

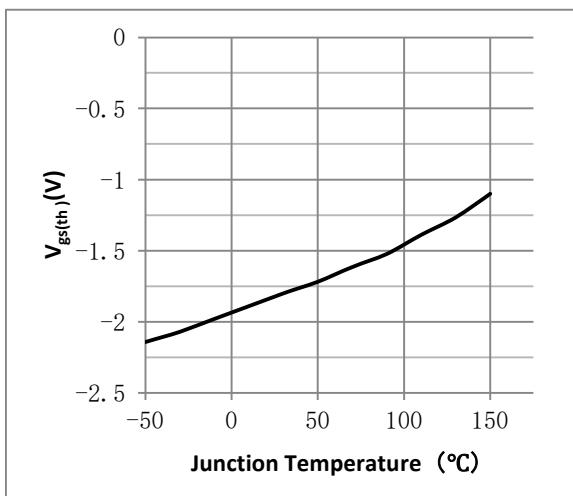


Fig.6 Resistance V.S Drain Current

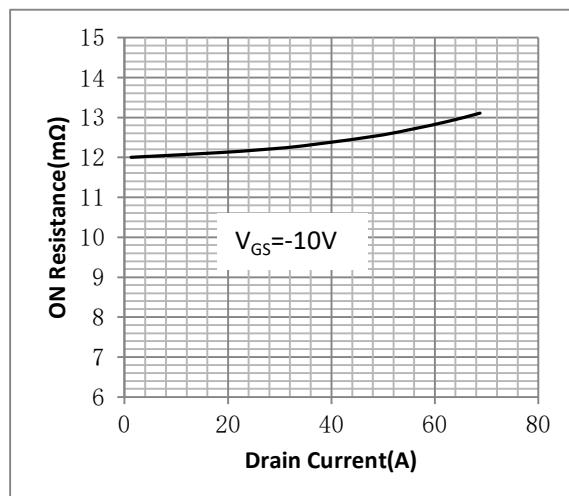


Fig.7 On-Resistance VS Gate Source Voltage

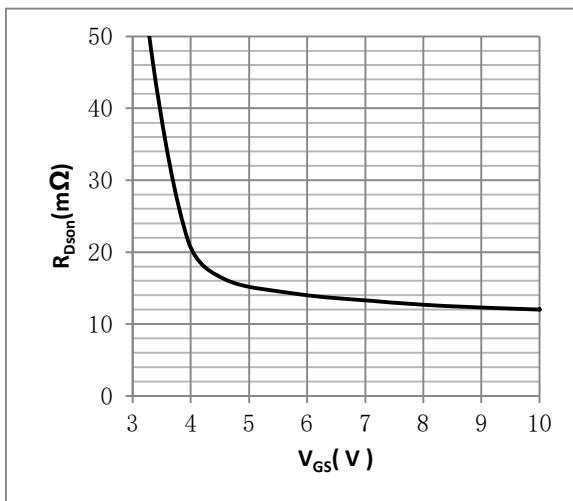


Fig.8 On-Resistance V.S Junction Temperature

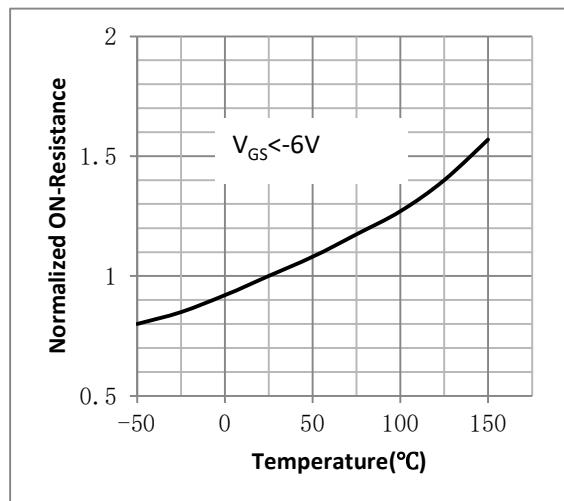


Figure 9. Diode Forward Voltage vs. Current

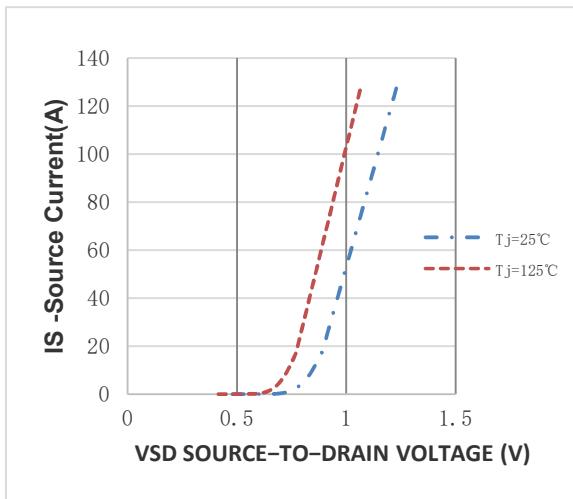


Figure 10. Transfer Characteristics

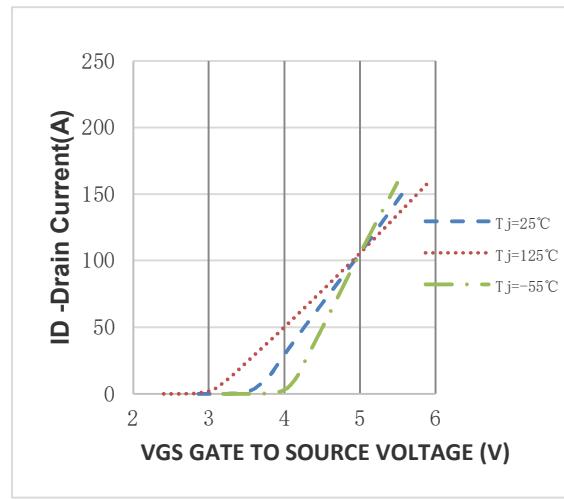


Fig.11 Safe Operating Area

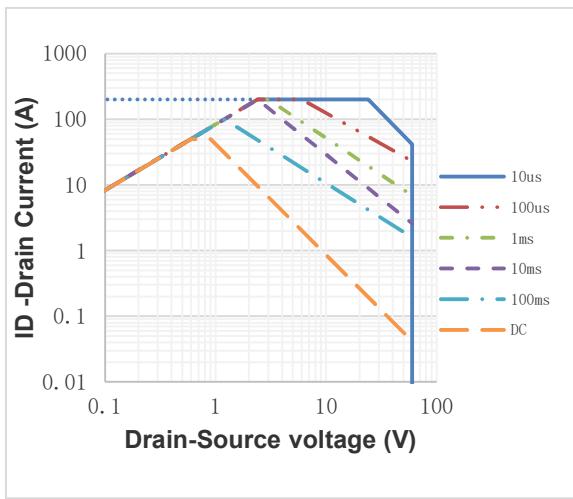
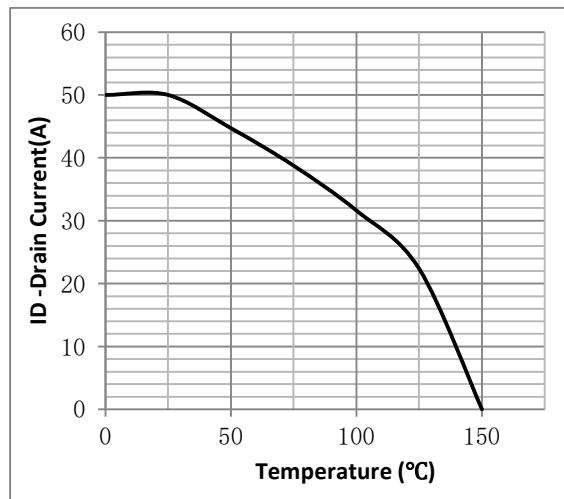
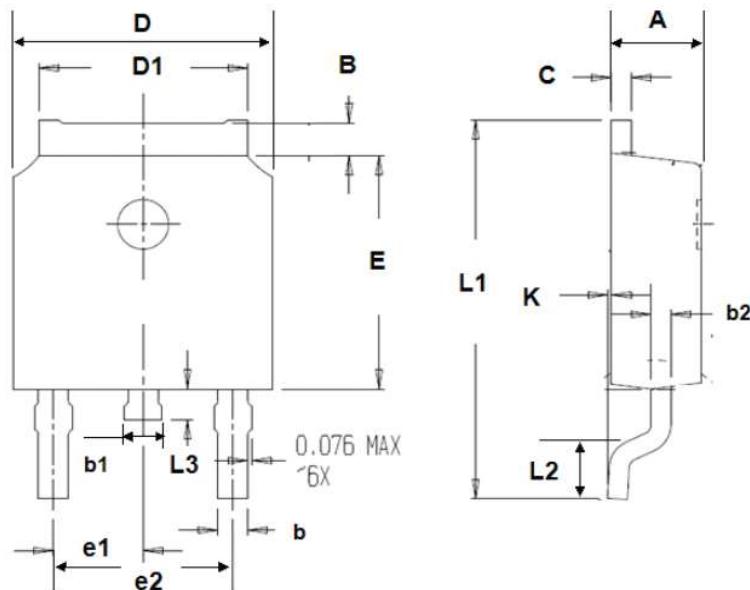


Fig.12 ID vs. Case Temperature^②



•TO-252 Package Outline

SYMBOL	min	max	SYMBOL	min	max
A	2.10	2.50	B	0.85	1.25
b	0.50	0.90	b1	0.50	0.90
b2	0.45	0.70	C	0.45	0.70
D	6.30	6.75	D1	5.10	5.50
E	5.30	6.30	e1	2.24	2.35
L1	9.20	10.60	e2	4.43	4.75
L2	0.90	1.75	L3	0.60	1.10
K	0.00	0.23			



Note:

① Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate;

② Practically the current will be limited by PCB, thermal design and operating temperature. VGS=-10V.

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Revision History

Version	Date	Change
A	2021.2.3	
B	2022.9.7	1.Add Reach, HF figure, 2.ID modify